


4/16/07

SHEET 1 OF 1

| Form PTO 1449 (Modified) | | U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE | | ATTY DOCKET NO. 243028US0DIV | | SERIAL NO. NEW APPLICATION | |
|---|--------------------|--|-------------------------------|--|--------------|-------------------------------|--|
| LIST OF REFERENCES CITED BY APPLICANT | | | | APPLICANT Toshimitsu TETSUI, et al. | | 10/667651 | |
|  | | | | FILING DATE HEREWITH | | GROUP 1742 | |
| U.S. PATENT DOCUMENTS | | | | | | | |
| EXAMINER INITIAL | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB CLASS | FILING DATE IF APPROPRIATE | |
| | AA 5,226,985 | 07-19-93 | Y-W. KIM et al. | | | | |
| | AB 5,338,729 | 09-24-98 | Y-W. KIM, et al. | | | | |
| | AC 5,442,847 | 08-22-95 | S.I. SEMIATIN, et al. | | | | |
| | AD 5,946,351 | 12-08-98 | N. MASAHASHI, et al. | | | | |
| | AE | | | | | | |
| | AF | | | | | | |
| | AG | | | | | | |
| | AH | | | | | | |
| | AI | | | | | | |
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| | AL | | | | | | |
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| | AN | | | | | | |
| FOREIGN PATENT DOCUMENTS | | | | | | | |
| | DOCUMENT NUMBER | DATE | COUNTRY | TRANSLATION | | | |
| | | | | YES | NO | | |
| | AO 64-042539 | 02-14-89 | JAPAN | | X | | |
| | AP 1-298127 | 12-01-89 | JAPAN | | X | | |
| | AQ 6-049565 | 02-22-94 | JAPAN | | X | | |
| | AR 6-0414661 | 02-15-94 | JAPAN | | X | | |
| jm | AS 62-000215 | 01-06-87 | JAPAN (no abstract available) | | X | | |
| | AT 4-088630 | 03-09-92 | JAPAN | | X | | |
| | AU 4,124,236 | 04-24-92 | JAPAN | | X | | |
| | AV 6-49024 | 02-22-94 | JAPAN | | X | | |
| OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.) | | | | | | | |
| | AW | D. ZHANG et al., Intermetallics, Vol. 7, No. 10, XP-004177382, pgs. 1081-1087, "Characterization of Controlled Microstructures in A1TiAl (Cr, Mo, Si, B) ALLOY," October 1999. | | | | | |
| | AX | "ASM Handbook: Vol. 3 Alloy Phase Diagrams," ASM International, 1992, p. 254. | | | | | |
| | AY | | | | | | |
| | AZ | <input type="checkbox"/> Additional References sheet(s) attached | | | | | |
| Examiner <i>jm</i> | | | | Date Considered 7/15/07 | | | |

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

* the above crossed out references have been previously considered